



SEMITRANS™ 2

Superfast NPT-IGBT Modules

SKM 75GB063D

SKM 75GAR063D

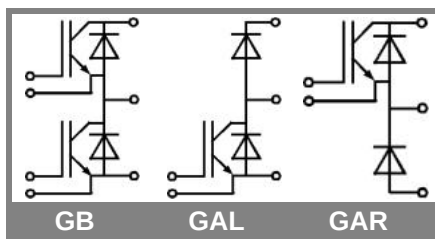
SKM 75GAL063D

Features

- N channel, homogeneous Si-structure (NPT-Non punch-through IGBT)
- Low tail current with low temperature dependence
- High short circuit capability, self limiting if term. G is clamped to E
- Pos. temp.-coeff. of V_{CEsat}
- Very low C_{ies} , C_{oes} , C_{res}
- Latch-up free
- Fast & soft inverse CAL diodes
- Isolated copper baseplate using DBC Direct Copper Bonding Technology without hard mould
- Large clearance (10 mm) and creepage distances (20 mm)

Typical Applications

- Switching (not for linear use)
- Switched mode power supplies
- UPS
- Three phase inverters for servo / AC motor speed control
- Pulse frequencies also > 10kHz



Absolute Maximum Ratings		$T_c = 25\text{ °C}$, unless otherwise specified	
Symbol	Conditions	Values	Units
IGBT			
V_{CES}		600	V
I_C	$T_c = 25\text{ (75) °C}$	100 (75)	A
I_{CRM}	$t_p = 1\text{ ms}$	150	A
V_{GES}		± 20	V
T_{vj} , (T_{stg})	$T_{OPERATION} \leq T_{stg}$	- 40 ... + (125) 150	°C
V_{isol}	AC, 1 min.	2500	V

Inverse diode			
I_F	$T_c = 25\text{ (80) °C}$	75 (50)	A
I_{FRM}	$t_p = 1\text{ ms}$	150	A
I_{FSM}	$t_p = 10\text{ ms}$; sin.; $T_j = 150\text{ °C}$	440	A

Freewheeling diode			
I_F	$T_c = 25\text{ (80) °C}$	100 (75)	A
I_{FRM}	$t_p = 1\text{ ms}$	200	A
I_{FSM}	$t_p = 10\text{ ms}$; sin.; $T_j = 150\text{ °C}$	720	A

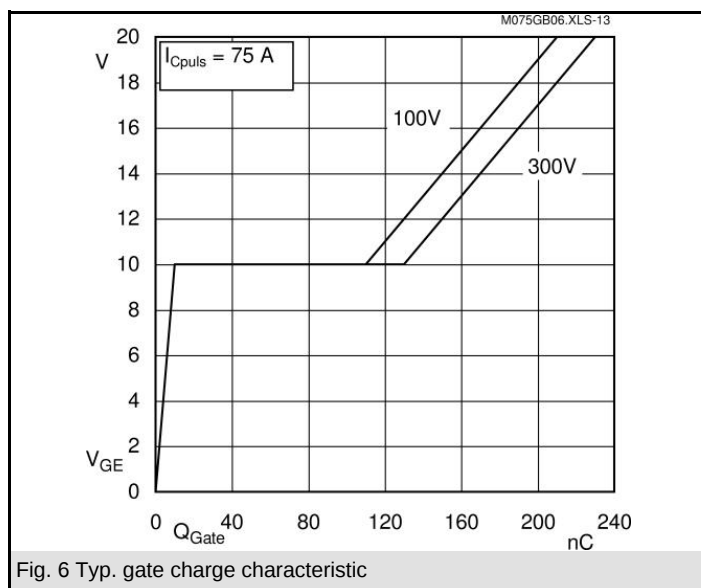
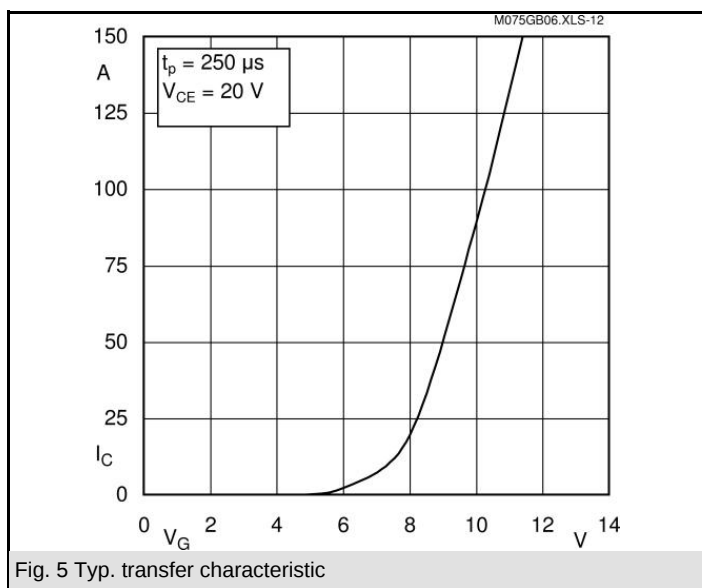
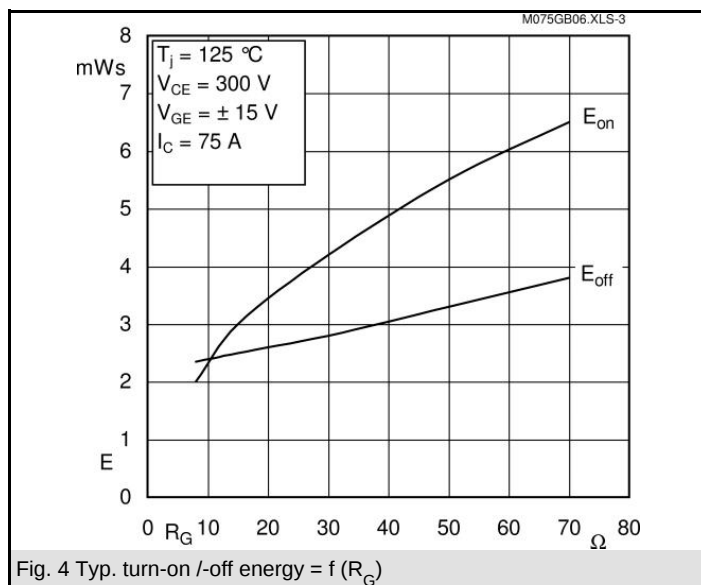
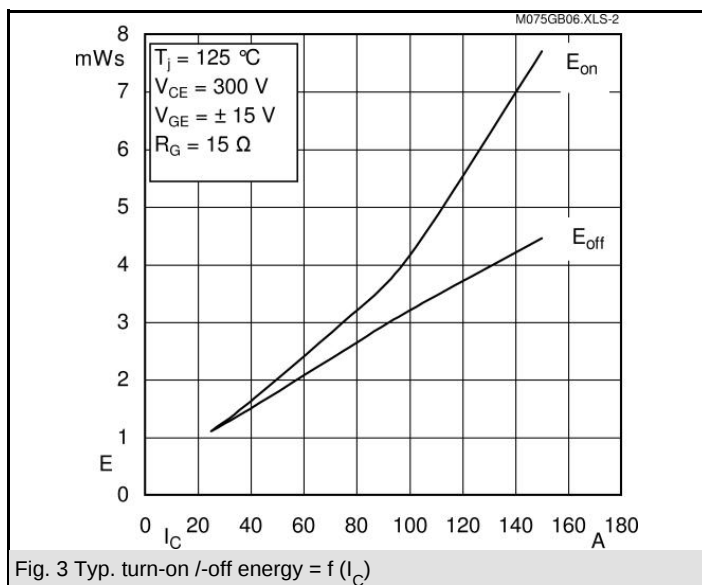
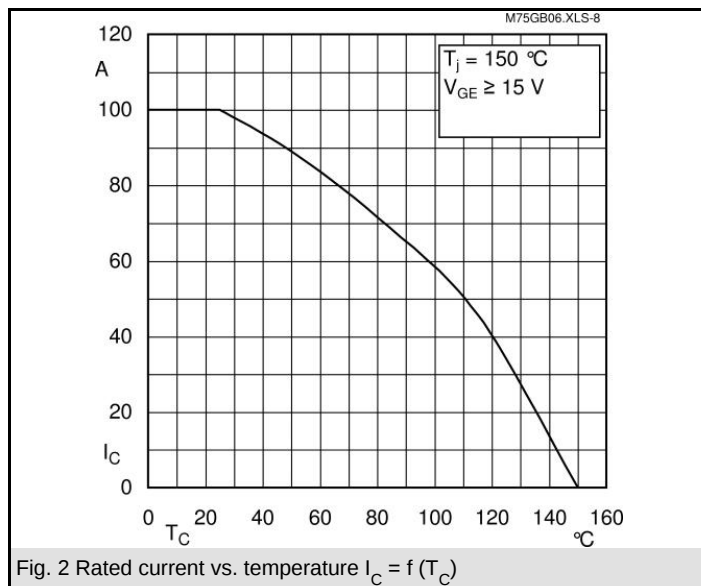
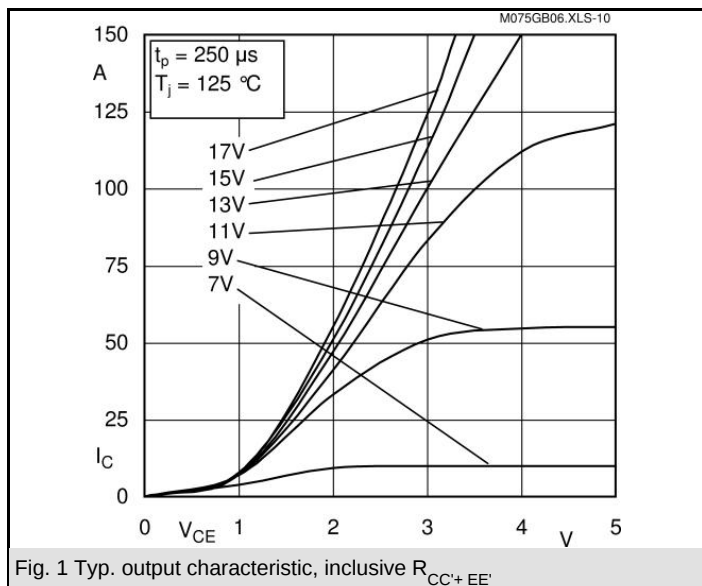
Characteristics		$T_c = 25\text{ °C}$, unless otherwise specified			
Symbol	Conditions	min.	typ.	max.	Units
IGBT					
$V_{GE(th)}$	$V_{GE} = V_{CE}$, $I_C = 1\text{ mA}$	4,5	5,5	6,5	V
I_{CES}	$V_{GE} = 0$, $V_{CE} = V_{CES}$, $T_j = 25\text{ (125) °C}$		0,1	0,3	mA
$V_{CE(TO)}$	$T_j = 25\text{ (125) °C}$		1,05 (1)		V
r_{CE}	$V_{GE} = 15\text{ V}$, $T_j = 25\text{ (125) °C}$		14 (18,7)		mΩ
$V_{CE(sat)}$	$I_{Cnom} = 75\text{ A}$, $V_{GE} = 15\text{ V}$, chip level		2,1 (2,4)	2,5 (2,8)	V
C_{ies}	under following conditions		4,2		nF
C_{oes}	$V_{GE} = 0$, $V_{CE} = 25\text{ V}$, $f = 1\text{ MHz}$		0,5		nF
C_{res}			0,3		nF
L_{CE}				30	nH
$R_{CC'+EE'}$	res., terminal-chip $T_c = 25\text{ (125) °C}$		0,75 (1)		mΩ
$t_{d(on)}$	$V_{CC} = 300\text{ V}$, $I_{Cnom} = 75\text{ A}$		60		ns
t_r	$R_{Gon} = R_{Goff} = 15\text{ Ω}$, $T_j = 125\text{ °C}$		50		ns
$t_{d(off)}$	$V_{GE} = \pm 15\text{ V}$		350		ns
t_f			35		ns
$E_{on} (E_{off})$			3 (2,5)		mJ

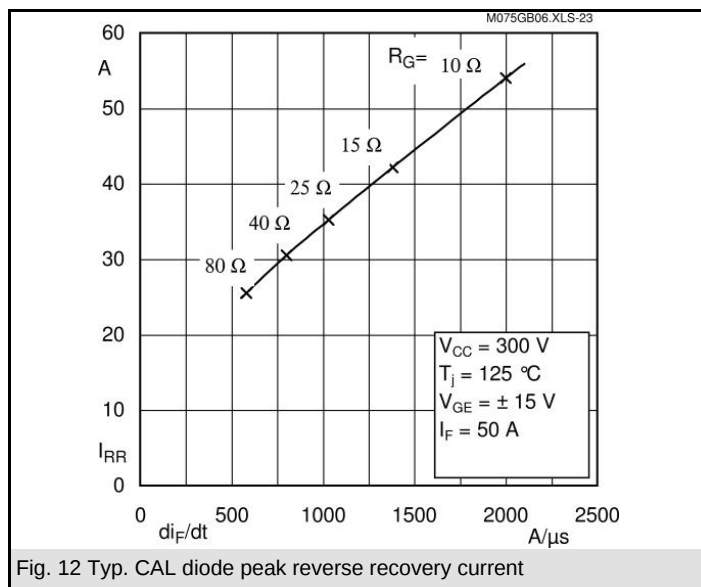
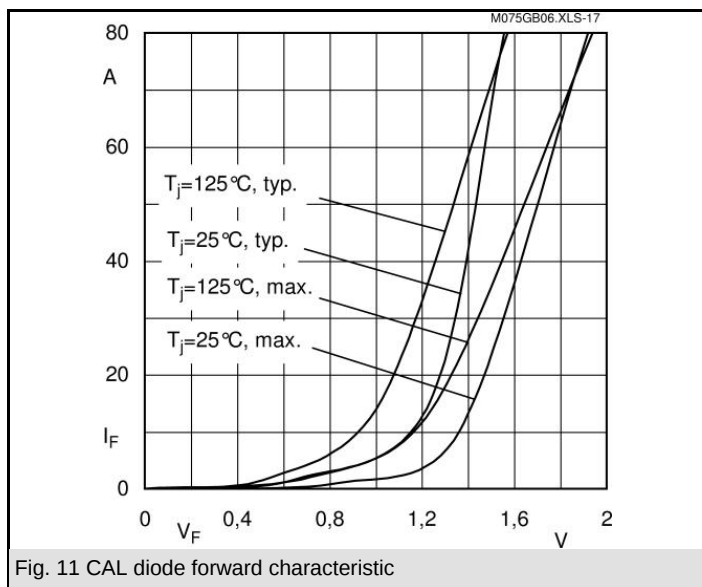
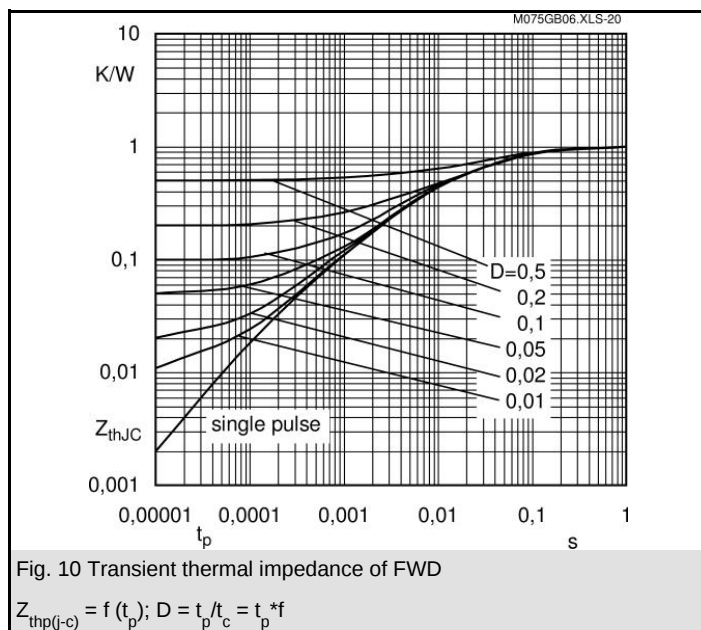
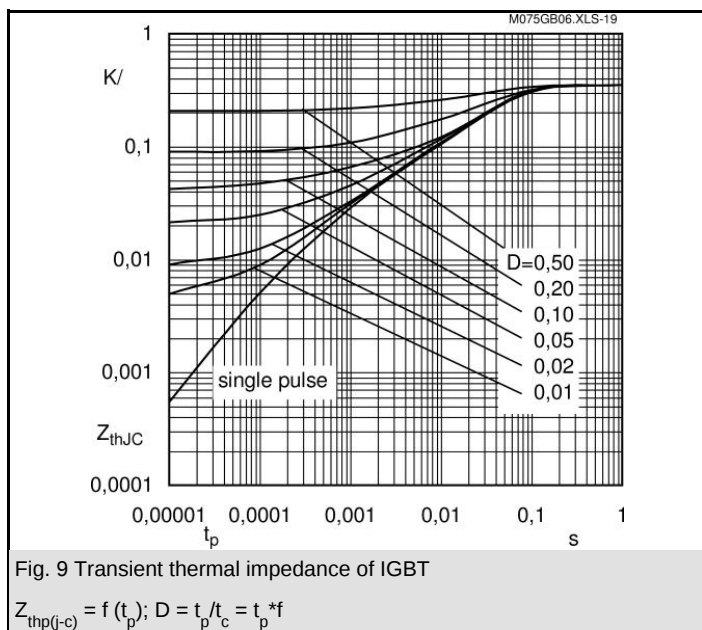
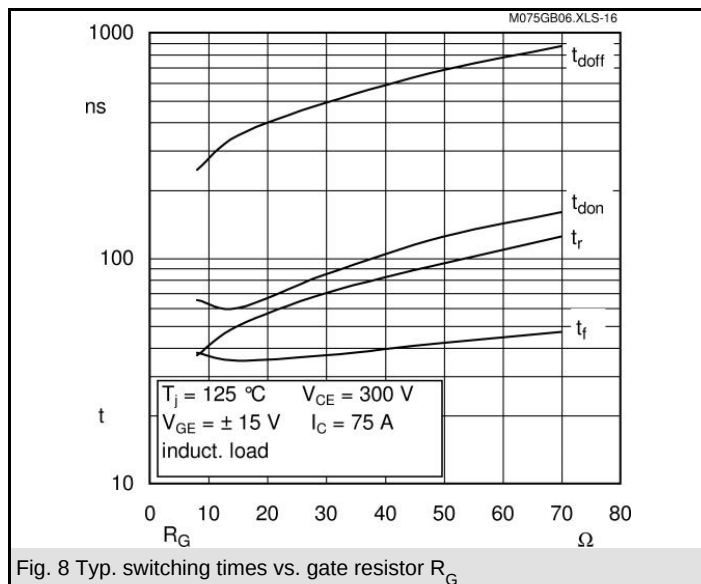
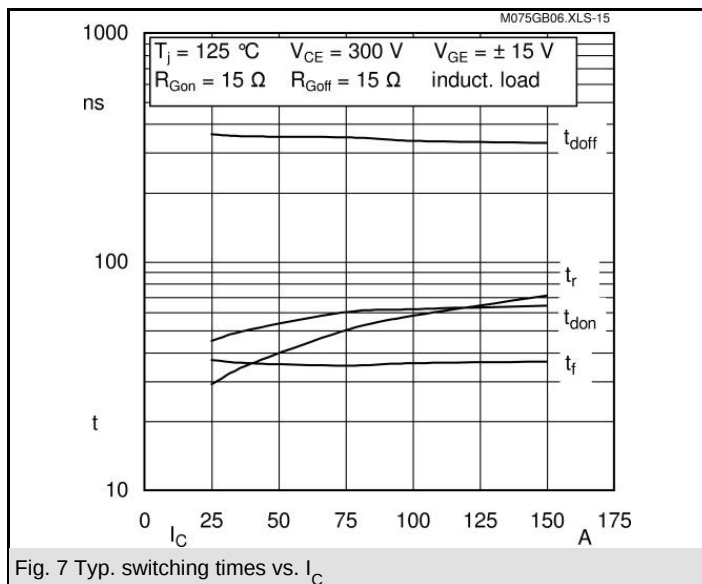
Inverse diode			
$V_F = V_{EC}$	$I_{Fnom} = 75\text{ A}$; $V_{GE} = 0\text{ V}$; $T_j = 25\text{ (125) °C}$	1,55 (1,55)	1,9
$V_{(TO)}$	$T_j = 125\text{ () °C}$		0,9
r_T	$T_j = 125\text{ () °C}$	10	13,3
I_{RRM}	$I_{Fnom} = 75\text{ A}$; $T_j = 125\text{ () °C}$	30	
Q_{rr}	$di/dt = 800\text{ A/μs}$	3,7	
E_{rr}	$V_{GE} = 0\text{ V}$		

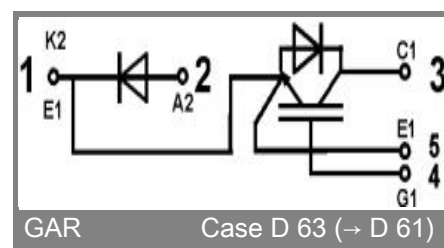
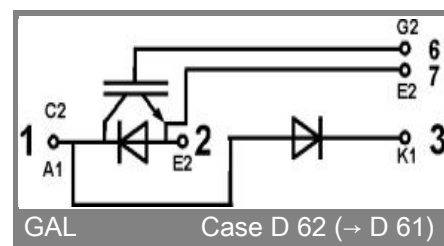
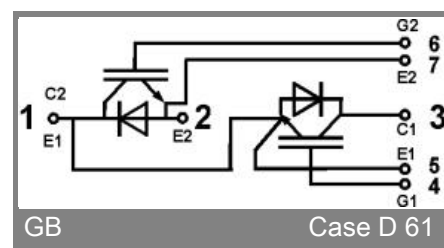
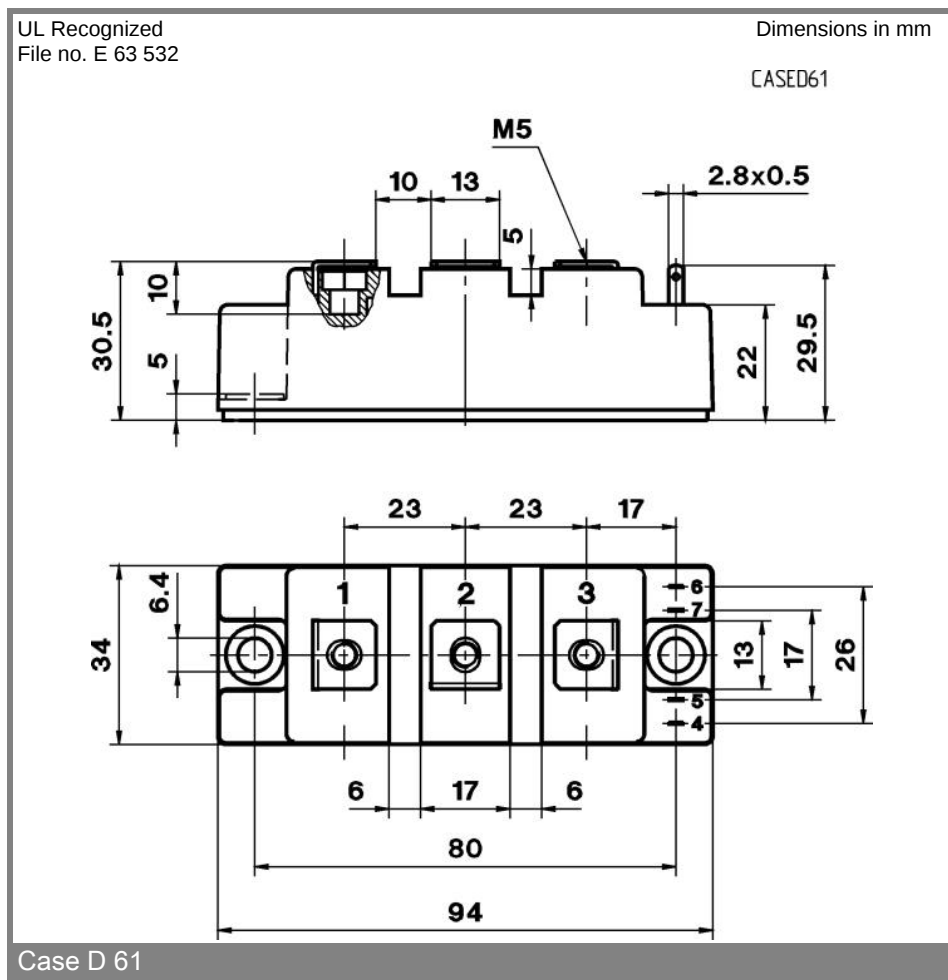
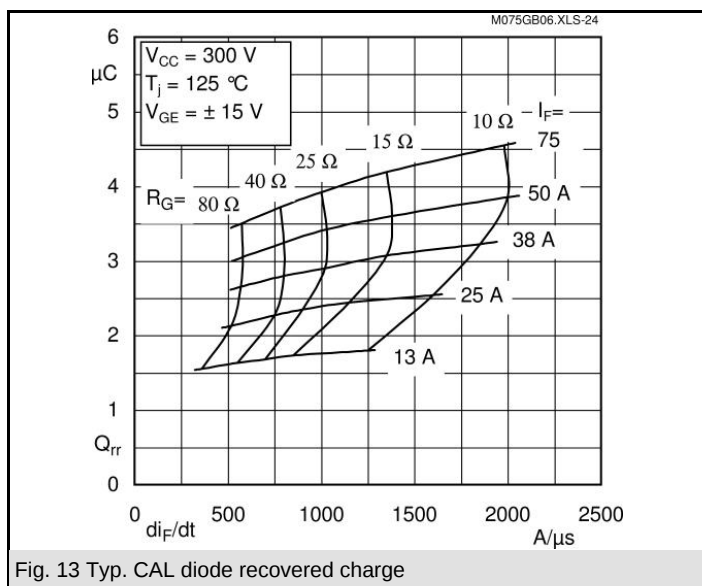
FWD			
$V_F = V_{EC}$	$I_F = 100\text{ A}$; $V_{GE} = 0\text{ V}$; $T_j = 25\text{ (125) °C}$	1,55 (1,55)	1,9
$V_{(TO)}$	$T_j = 125\text{ () °C}$		0,9
r_T	$T_j = 125\text{ () °C}$	8	10
I_{RRM}	$I_F = 100\text{ A}$; $T_j = 125\text{ () °C}$	44	
Q_{rr}	$di/dt = 0\text{ A/μs}$	6	
E_{rr}	$V_{GE} = V$		

Thermal characteristics			
$R_{th(j-c)}$	per IGBT	0,35	K/W
$R_{th(j-c)D}$	per Inverse Diode	1	K/W
$R_{th(j-c)FD}$	per FWD	0,6	K/W
$R_{th(c-s)}$	per module	0,05	K/W

Mechanical data			
M_s	to heatsink M6	3	Nm
M_t	to terminals M5	2,5	Nm
w			160







This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

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